

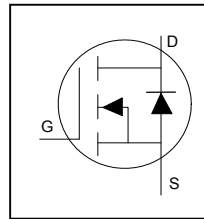
**Application**

- Brushed Motor drive applications
- BLDC Motor drive applications
- Battery powered circuits
- Half-bridge and full-bridge topologies
- Synchronous rectifier applications
- Resonant mode power supplies
- OR-ing and redundant power switches
- DC/DC and AC/DC converters
- DC/AC Inverters

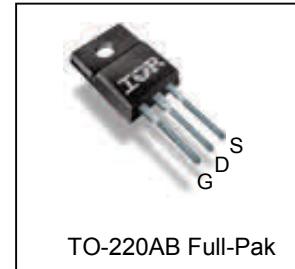
**Benefits**

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability
- Lead-Free, RoHS Compliant

HEXFET® Power MOSFET

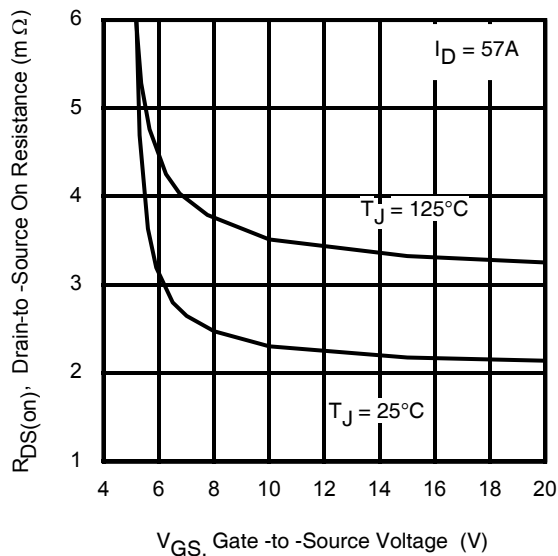


|                                |              |
|--------------------------------|--------------|
| <b>V<sub>DSS</sub></b>         | <b>40V</b>   |
| <b>R<sub>DS(on)</sub> typ.</b> | <b>2.0mΩ</b> |
|                                | <b>max</b>   |
| <b>I<sub>D</sub></b>           | <b>95A</b>   |

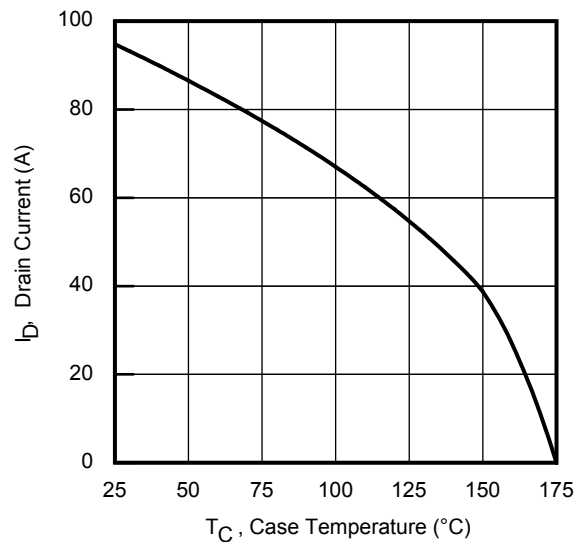


|          |          |          |
|----------|----------|----------|
| <b>G</b> | <b>D</b> | <b>S</b> |
| Gate     | Drain    | Source   |

| Base part number | Package Type    | Standard Pack |          | Orderable Part Number |
|------------------|-----------------|---------------|----------|-----------------------|
|                  |                 | Form          | Quantity |                       |
| IRFI7440GPbF     | TO-220 Full-Pak | Tube          | 50       | IRFI7440GPbF          |



**Fig 1.** Typical On-Resistance vs. Gate Voltage



**Fig 2.** Maximum Drain Current vs. Case Temperature

**Absolute Maximum Rating**

| Symbol                          | Parameter   | Max.                | Units |
|---------------------------------|---|---------------------|-------|
| $I_D @ T_C = 25^\circ\text{C}$  | Continuous Drain Current, $V_{GS} @ 10\text{V}$         | 95                  | A     |
| $I_D @ T_C = 100^\circ\text{C}$ | Continuous Drain Current, $V_{GS} @ 10\text{V}$         | 67                  |       |
| $I_{DM}$                        | Pulsed Drain Current ①                                  | 380                 |       |
| $P_D @ T_C = 25^\circ\text{C}$  | Maximum Power Dissipation                               | 42                  | W     |
|                                 | Linear Derating Factor                                  | 0.28                | W/°C  |
| $V_{GS}$                        | Gate-to-Source Voltage                                  | $\pm 20$            | V     |
| $T_J$                           | Operating Junction and                                  | -55 to + 175        | °C    |
| $T_{STG}$                       | Storage Temperature Range                               |                     |       |
|                                 | Soldering Temperature, for 10 seconds (1.6mm from case) |                     |       |
|                                 | Mounting Torque, 6-32 or M3 Screw                       | 10 lbf·in (1.1 N·m) |       |

**Avalanche Characteristics**

|                              |                                 |                           |    |
|------------------------------|---------------------------------|---------------------------|----|
| $E_{AS}$ (Thermally limited) | Single Pulse Avalanche Energy ② | 201                       | mJ |
| $E_{AS}$ (Thermally limited) | Single Pulse Avalanche Energy ③ | 407                       |    |
| $I_{AR}$                     | Avalanche Current ①             | See Fig. 15, 16, 23a, 23b | A  |
| $E_{AR}$                     | Repetitive Avalanche Energy ①   |                           | mJ |

**Thermal Resistance**

| Symbol          | Parameter           | Typ. | Max. | Units |
|-----------------|---------------------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case ⑦  | —    | 3.6  | °C/W  |
| $R_{\theta JA}$ | Junction-to-Ambient | —    | 65   |       |

**Static @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

| Symbol                          | Parameter                            | Min. | Typ. | Max. | Units | Conditions   |
|---------------------------------|--------------------------------------|------|------|------|-------|--|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 40   | —    | —    | V     | $V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$                         |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 37   | —    | mV/°C | Reference to $25^\circ\text{C}, I_D = 2\text{mA}$ ①                |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | 2.0  | 2.5  | mΩ    | $V_{GS} = 10\text{V}, I_D = 57\text{A}$                            |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 2.2  | 3.0  | 3.9  | V     | $V_{DS} = V_{GS}, I_D = 100\mu\text{A}$                            |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —    | 1.0  | μA    | $V_{DS} = 40\text{V}, V_{GS} = 0\text{V}$                          |
|                                 |                                      | —    | —    | 150  |       | $V_{DS} = 40\text{V}, V_{GS} = 0\text{V}, T_J = 125^\circ\text{C}$ |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —    | 100  | nA    | $V_{GS} = 20\text{V}$  |
|                                 | Gate-to-Source Reverse Leakage       | —    | —    | -100 |       | $V_{GS} = -20\text{V}$   |
| $R_G$                           | Gate Resistance                      | —    | 2.3  | —    | Ω     |  |

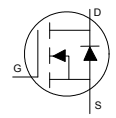
**Notes:**

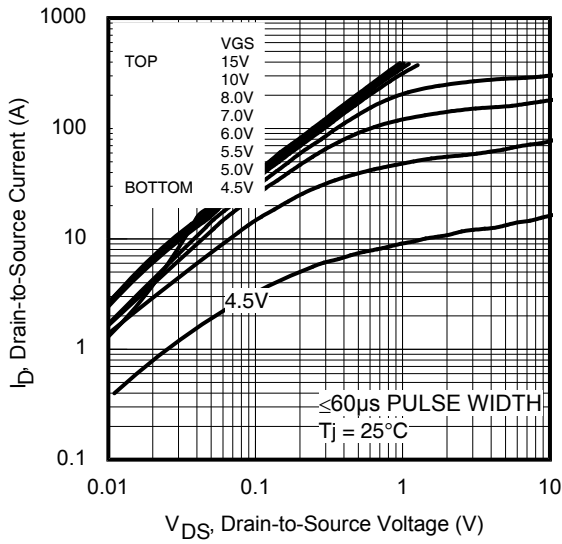
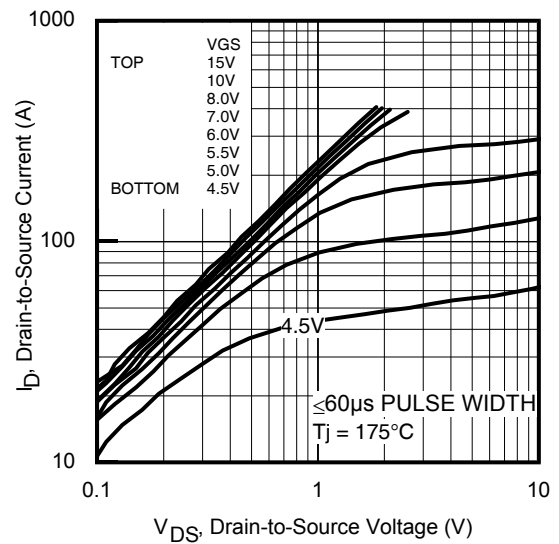
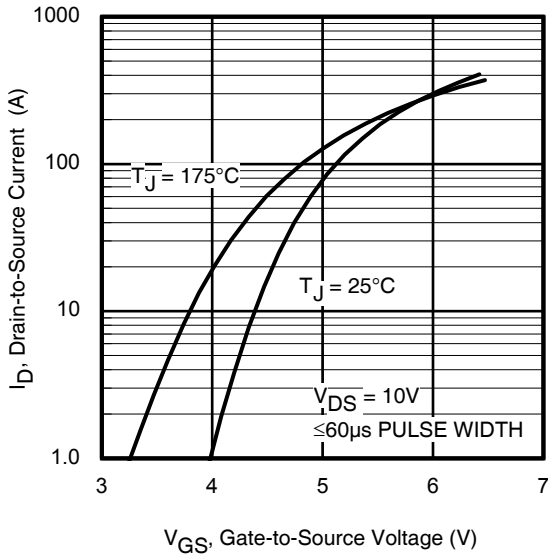
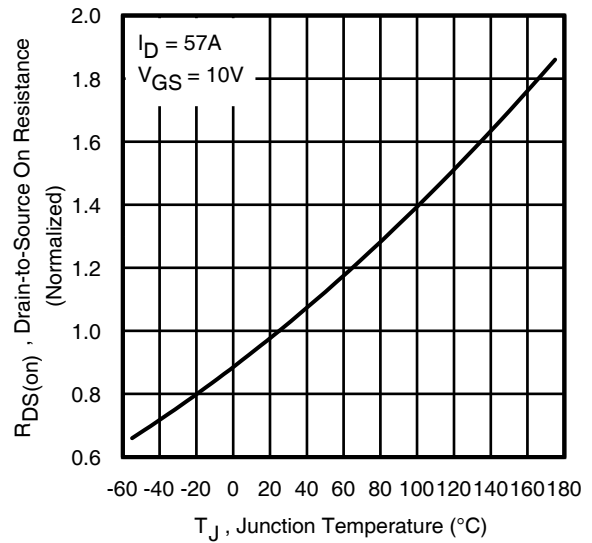
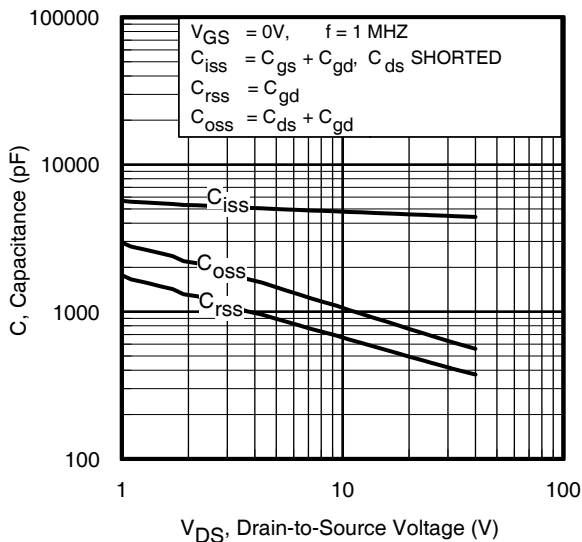
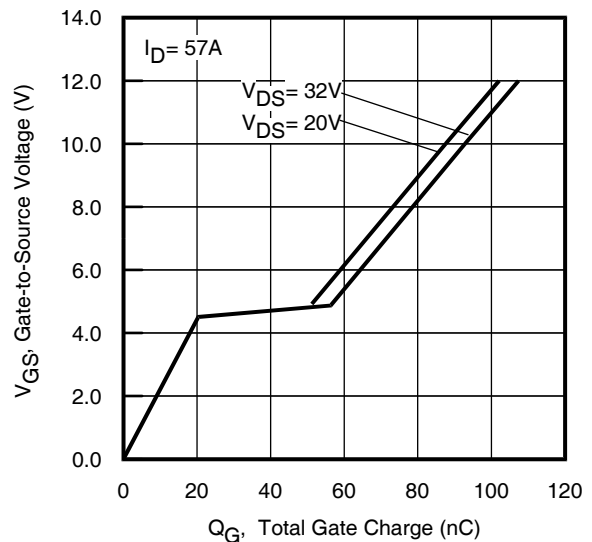
- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by  $T_{Jmax}$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 124\mu\text{H}$ ,  $R_G = 50\Omega$ ,  $I_{AS} = 57\text{A}$ ,  $V_{GS} = 10\text{V}$ .
- ③  $I_{SD} \leq 57\text{A}$ ,  $di/dt \leq 962\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 175^\circ\text{C}$ .
- ④ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ⑤  $C_{oss}$  eff. (TR) is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- ⑥  $C_{oss}$  eff. (ER) is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- ⑦  $R_\theta$  is measured at  $T_J$  approximately  $90^\circ\text{C}$ .
- ⑧ Limited by  $T_{Jmax}$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 1\text{mH}$ ,  $R_G = 50\Omega$ ,  $I_{AS} = 29\text{A}$ ,  $V_{GS} = 10\text{V}$ .

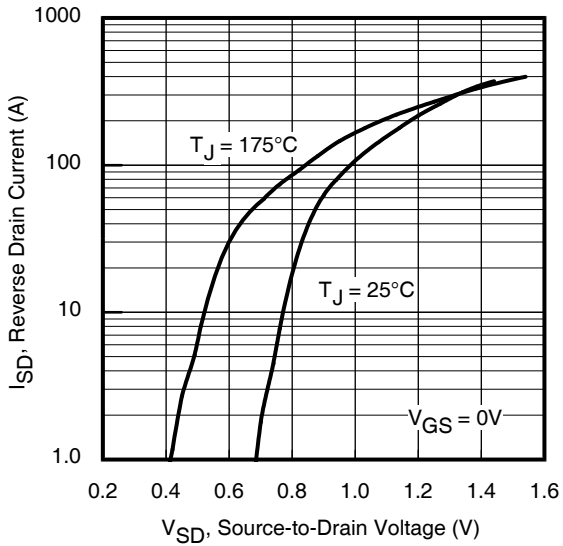
**Dynamic Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

| Symbol              | Parameter                                     | Min. | Typ. | Max. | Units | Conditions  |
|---------------------|---|------|------|------|-------|---|
| gfs                 | Forward Transconductance                      | 144  | —    | —    | S     | $V_{DS} = 10\text{V}, I_D = 57\text{A}$   |
| $Q_g$               | Total Gate Charge                             | —    | 88   | 132  | nC    | $I_D = 57\text{A}$<br>$V_{DS} = 20\text{V}$<br>$V_{GS} = 10\text{V}$                            |
| $Q_{gs}$            | Gate-to-Source Charge                         | —    | 22   | —    |       |   |
| $Q_{gd}$            | Gate-to-Drain Charge                          | —    | 30   | —    |       |   |
| $Q_{sync}$          | Total Gate Charge Sync. ( $Q_g - Q_{gd}$ )    | —    | 58   | —    |       |   |
| $t_{d(on)}$         | Turn-On Delay Time                            | —    | 11   | —    | ns    | $V_{DD} = 20\text{V}$<br>$I_D = 30\text{A}$<br>$R_G = 2.7\Omega$<br>$V_{GS} = 10\text{V}^{(4)}$ |
| $t_r$               | Rise Time                                     | —    | 42   | —    |       |   |
| $t_{d(off)}$        | Turn-Off Delay Time                           | —    | 56   | —    |       |   |
| $t_f$               | Fall Time                                     | —    | 36   | —    |       |   |
| $C_{iss}$           | Input Capacitance                             | —    | 4549 | —    | pF    | $V_{GS} = 0\text{V}$<br>$V_{DS} = 25\text{V}$<br>$f = 1.0\text{MHz}$ , See Fig.7                |
| $C_{oss}$           | Output Capacitance                            | —    | 689  | —    |       |   |
| $C_{riss}$          | Reverse Transfer Capacitance                  | —    | 450  | —    |       |   |
| $C_{oss\ eff.(ER)}$ | Effective Output Capacitance (Energy Related) | —    | 835  | —    |       |   |
| $C_{oss\ eff.(TR)}$ | Output Capacitance (Time Related)             | —    | 981  | —    |       |   |

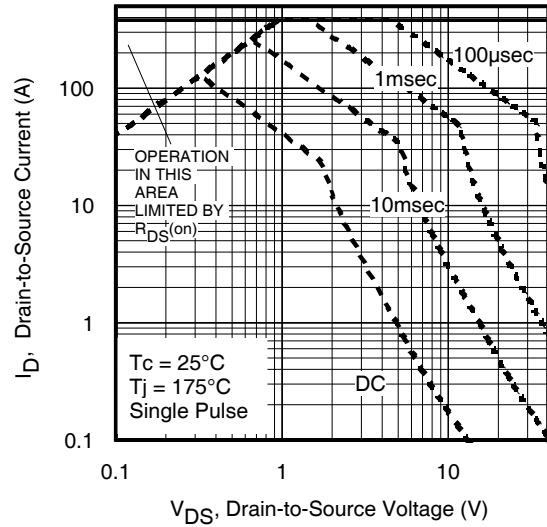
**Diode Characteristics**

| Symbol    | Parameter   | Min. | Typ. | Max. | Units | Conditions   |
|-----------|---|------|------|------|-------|--|
| $I_S$     | Continuous Source Current (Body Diode) <sup>(1)</sup> | —    | —    | 95   | A     | MOSFET symbol showing the integral reverse p-n junction diode.  |
| $I_{SM}$  | Pulsed Source Current (Body Diode) <sup>(1)</sup>     | —    | —    | 380  |       |  |
| $V_{SD}$  | Diode Forward Voltage                                 | —    | —    | 1.3  | V     | $T_J = 25^\circ\text{C}, I_S = 57\text{A}, V_{GS} = 0\text{V}^{(4)}$   |
| dv/dt     | Peak Diode Recovery dv/dt <sup>(3)</sup>              | —    | 5.1  | —    | V/ns  | $T_J = 175^\circ\text{C}, I_S = 57\text{A}, V_{DS} = 40\text{V}^{(4)}$   |
| $t_{rr}$  | Reverse Recovery Time                                 | —    | 36   | —    | ns    | $T_J = 25^\circ\text{C}$ $V_{DD} = 34\text{V}$<br>$T_J = 125^\circ\text{C}$ $I_F = 57\text{A}$ ,   |
|           |   | —    | 38   | —    |       |  |
| $Q_{rr}$  | Reverse Recovery Charge                               | —    | 45   | —    | nC    | $T_J = 25^\circ\text{C}$<br>$T_J = 125^\circ\text{C}$ $di/dt = 100\text{A}/\mu\text{s}^{(4)}$  |
|           |   | —    | 49   | —    |       |  |
| $I_{RRM}$ | Reverse Recovery Current                              | —    | 2.1  | —    | A     | $T_J = 25^\circ\text{C}$   |

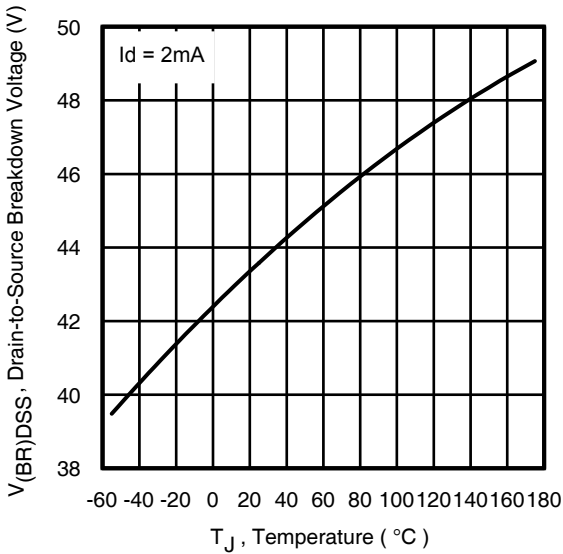

**Fig 3.** Typical Output Characteristics

**Fig 4.** Typical Output Characteristics

**Fig 5.** Typical Transfer Characteristics

**Fig 6.** Normalized On-Resistance vs. Temperature

**Fig 7.** Typical Capacitance vs. Drain-to-Source Voltage

**Fig 8.** Typical Gate Charge vs. Gate-to-Source Voltage



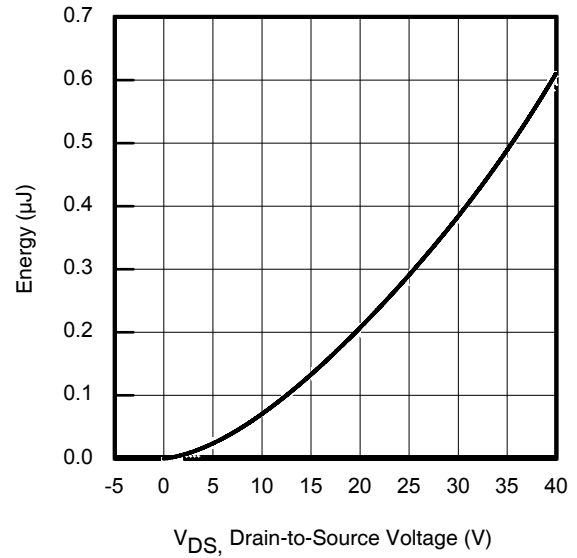
**Fig 9.** Typical Source-Drain Diode Forward Voltage



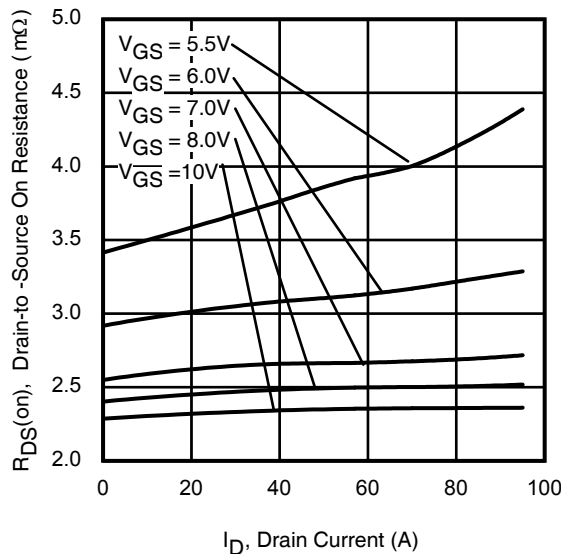
**Fig 10.** Maximum Safe Operating Area



**Fig 11.** Drain-to-Source Breakdown Voltage



**Fig 12.** Typical  $C_{oss}$  Stored Energy



**Fig 13.** Typical On-Resistance vs. Drain Current

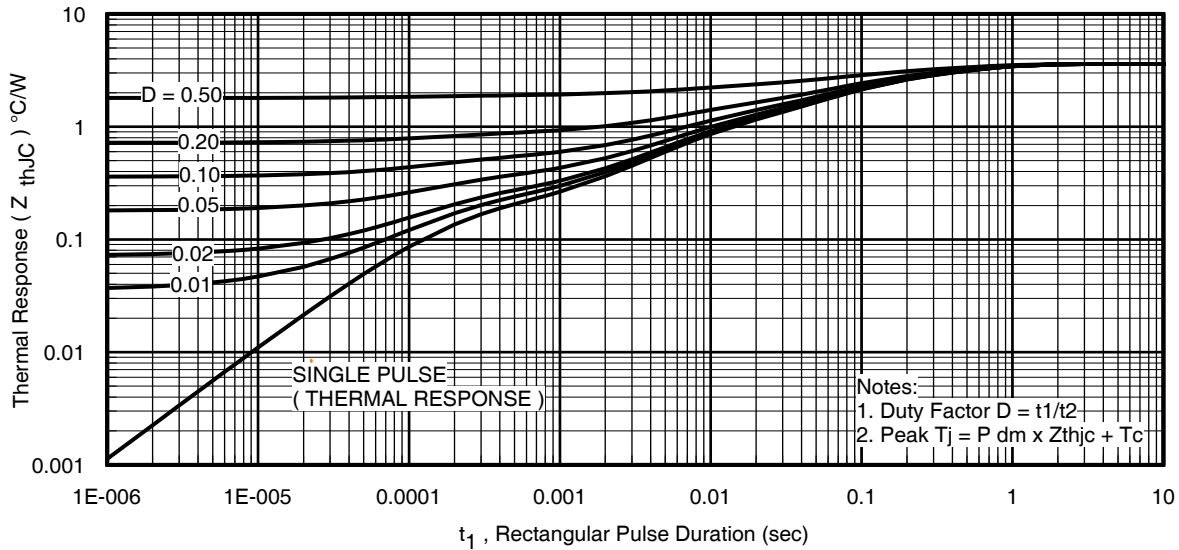


Fig 14. Maximum Effective Transient Thermal Impedance, Junction-to-Case

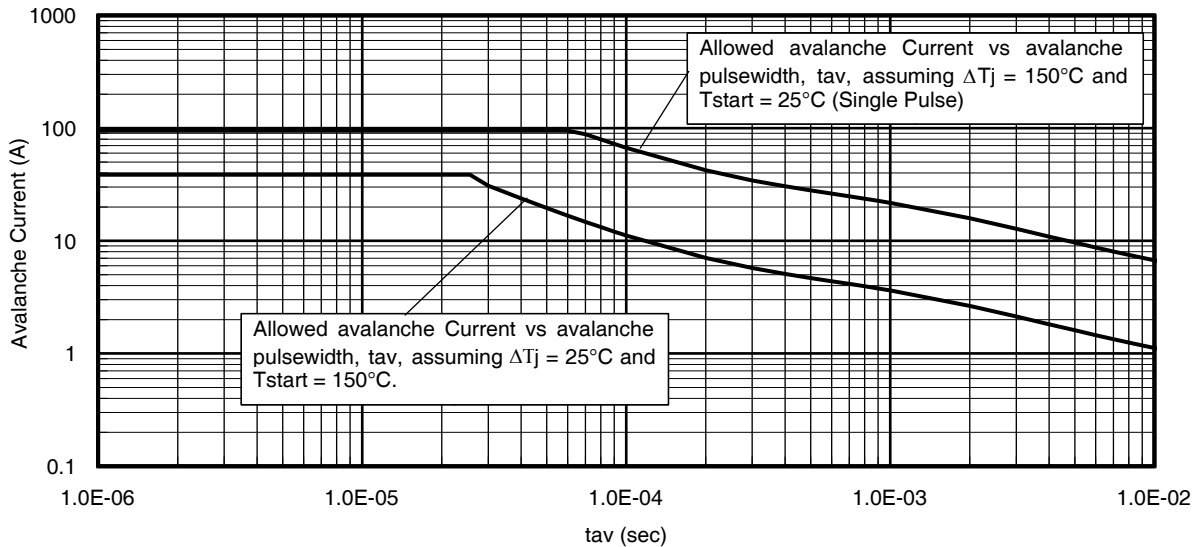


Fig 15. Avalanche Current vs. Pulse Width

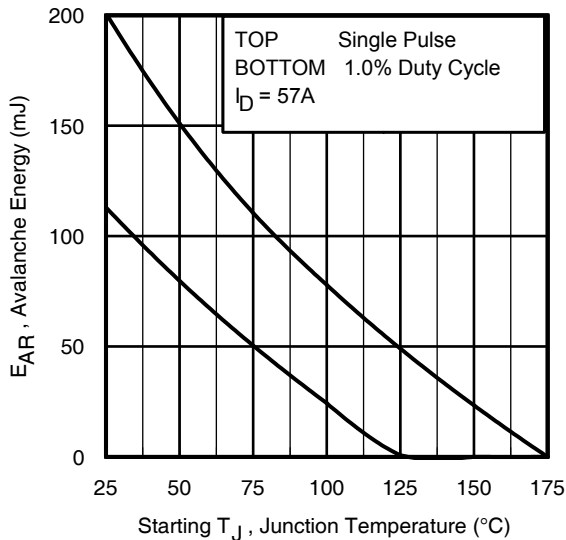


Fig 16. Maximum Avalanche Energy vs. Temperature

**Notes on Repetitive Avalanche Curves , Figures 15, 16:**  
(For further info, see AN-1005 at [www.irf.com](http://www.irf.com))

1. Avalanche failures assumption:  
Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 23a, 23b.
4.  $P_{D(ave)}$  = Average power dissipation per single avalanche pulse.
5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6.  $I_{av}$  = Allowable avalanche current.
7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 14, 15).  
 $t_{av}$  = Average time in avalanche.  
 $D$  = Duty cycle in avalanche =  $t_{av} \cdot f$   
 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see Figures 13)  
 $P_{D(ave)} = 1/2 ( 1.3 \cdot BV \cdot I_{av} ) = \Delta T / Z_{thJC}$   
 $I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$   
 $E_{AS(AR)} = P_{D(ave)} \cdot t_{av}$

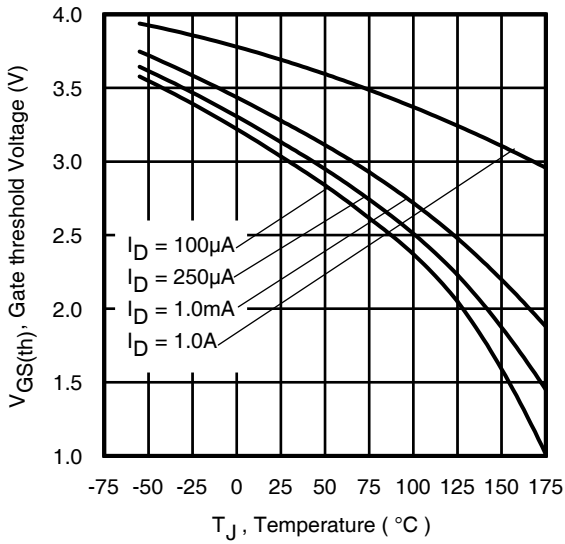


Fig 17. Threshold Voltage vs. Temperature

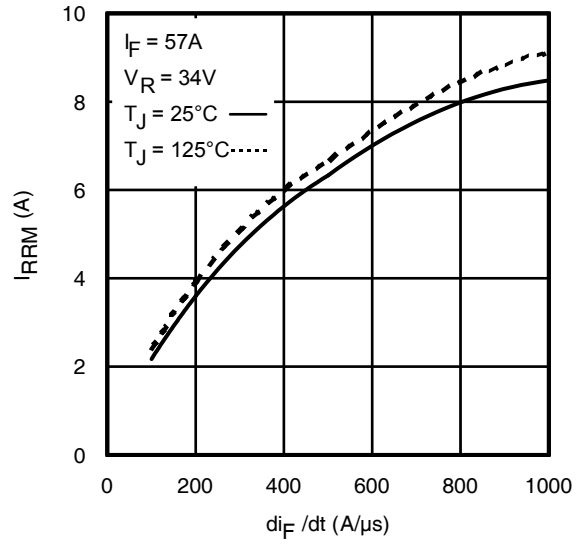


Fig 18. Typical Recovery Current vs.  $di_F/dt$

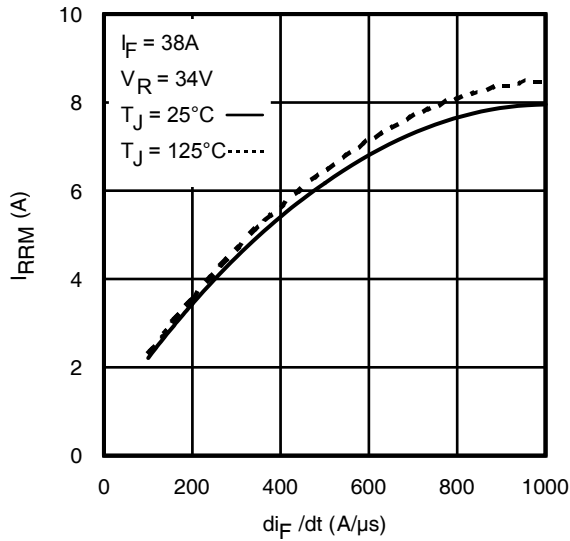


Fig 19. Typical Recovery Current vs.  $di_F/dt$

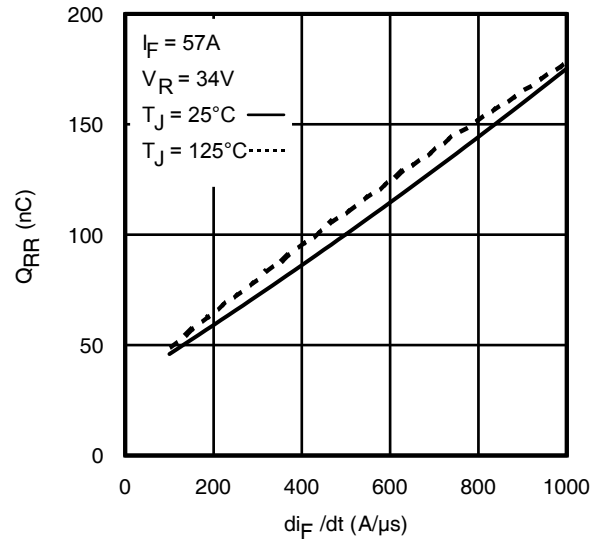


Fig 20. Typical Stored Charge vs.  $di_F/dt$

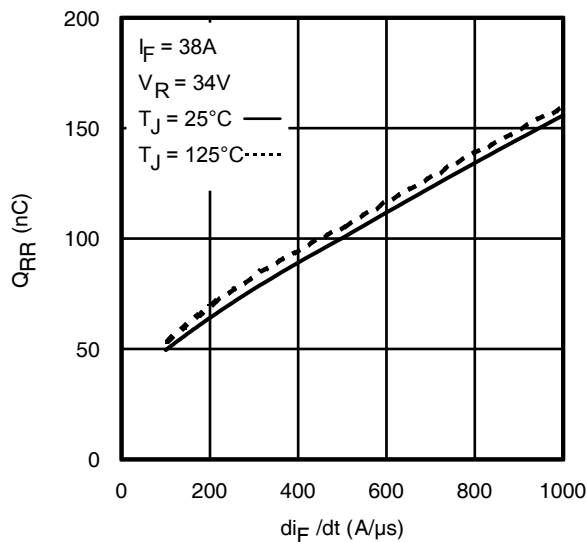


Fig 21. Typical Stored Charge vs.  $di_F/dt$

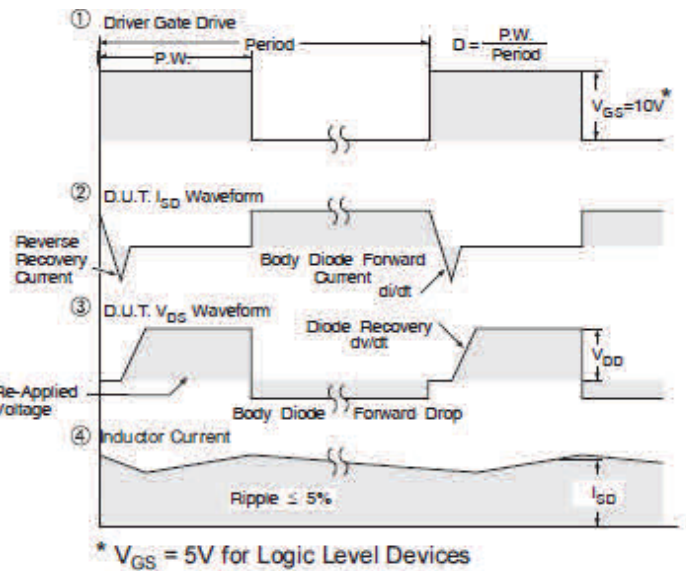
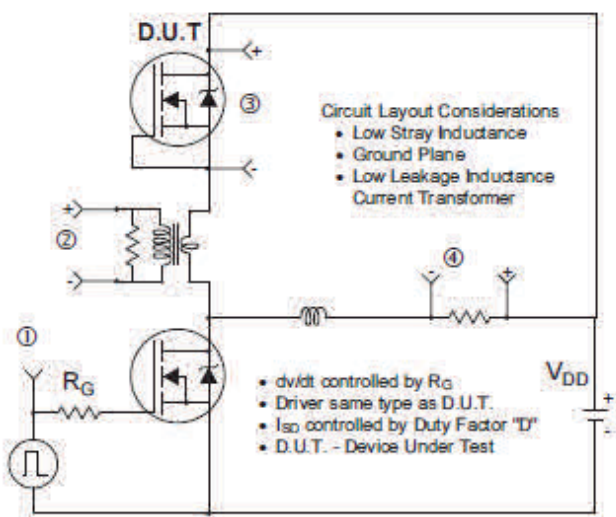


Fig 22. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

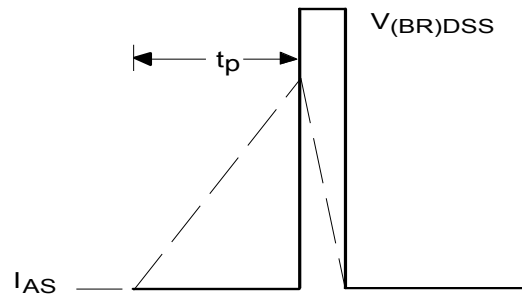
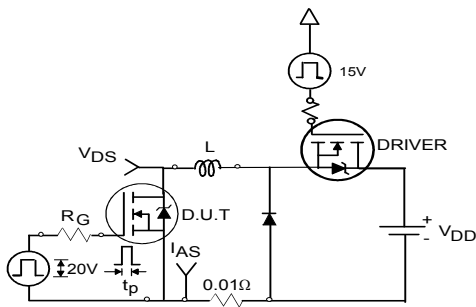


Fig 23a. Unclamped Inductive Test Circuit

Fig 23b. Unclamped Inductive Waveforms

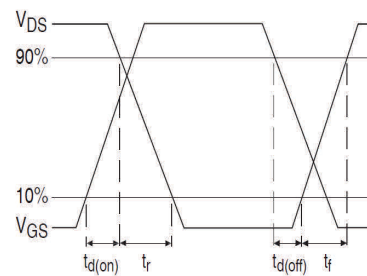
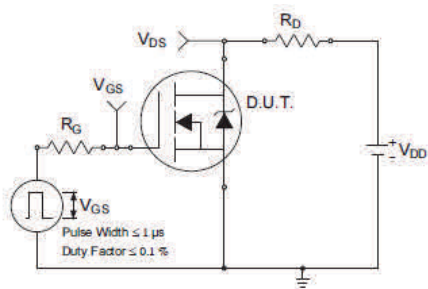


Fig 24a. Switching Time Test Circuit

Fig 24b. Switching Time Waveforms

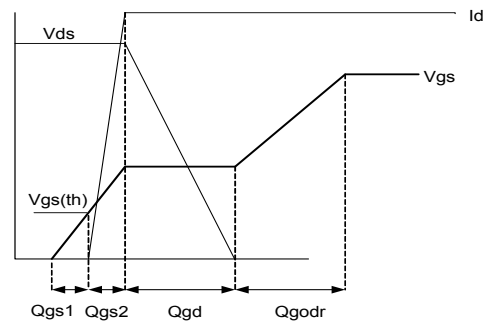
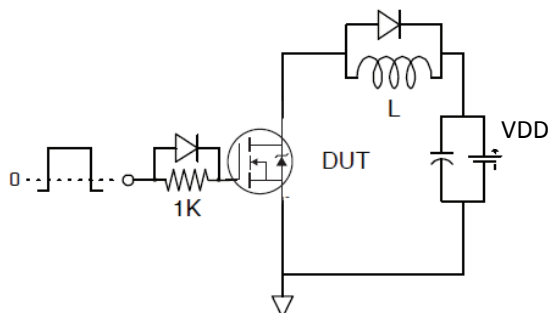
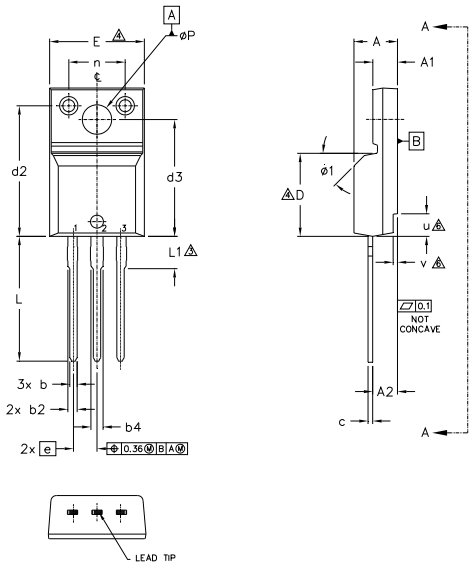


Fig 25a. Gate Charge Test Circuit

Fig 25b. Gate Charge Waveform

## TO-220 Full-Pak Package Outline (Dimensions are shown in millimeters (inches))



**NOTES:**

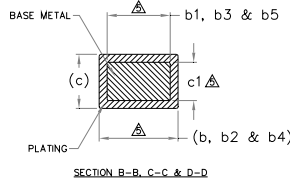
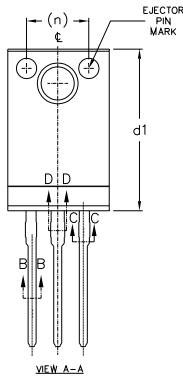
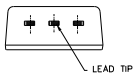
- 1.0 DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994.
- 2.0 DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3.0 LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.
- 4.0 DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTER MOST EXTREMES OF THE PLASTIC BODY.
- 5.0 DIMENSION b1, b3, b5 & c1 APPLY TO BASE METAL ONLY.
- 6.0 STEP OPTIONAL ON PLASTIC BODY DEFINED BY DIMENSIONS u & v.
- 7.0 CONTROLLING DIMENSION : INCHES.

**LEAD ASSIGNMENTS**

- HEXFEEET**  
 1.- GATE  
 2.- DRAIN  
 3.- SOURCE

**IGBTs, CoPACK**

- 1.- GATE  
 2.- COLLECTOR  
 3.- EMITTER

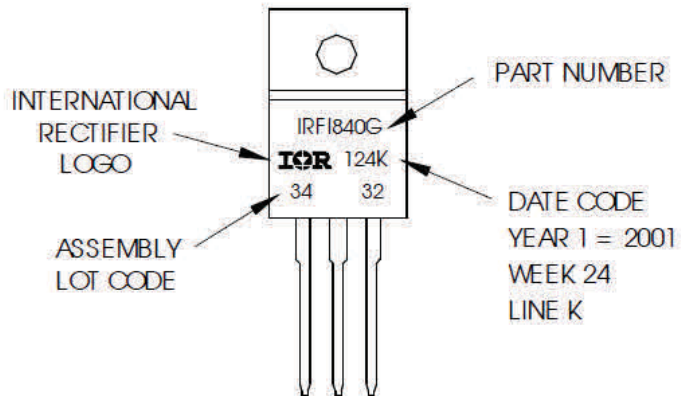


| SYMBOL   | DIMENSIONS  |       |          |      | NOTES |
|----------|-------------|-------|----------|------|-------|
|          | MILLIMETERS |       | INCHES   |      |       |
|          | MIN.        | MAX.  | MIN.     | MAX. |       |
| A        | 4.57        | 4.83  | .180     | .190 |       |
| A1       | 2.57        | 2.82  | .101     | .111 |       |
| A2       | 2.51        | 2.92  | .099     | .115 |       |
| b        | 0.61        | 0.94  | .024     | .037 |       |
| b1       | 0.61        | 0.89  | .024     | .035 | 5     |
| b2       | 0.76        | 1.27  | .030     | .050 |       |
| b3       | 0.76        | 1.22  | .030     | .048 | 5     |
| b4       | 1.02        | 1.52  | .040     | .060 |       |
| b5       | 1.02        | 1.47  | .040     | .058 | 5     |
| c        | 0.33        | 0.63  | .013     | .025 |       |
| c1       | 0.33        | 0.58  | .013     | .023 | 5     |
| D        | 8.66        | 9.80  | .341     | .386 | 4     |
| d1       | 15.80       | 16.13 | .622     | .635 |       |
| d2       | 13.97       | 14.22 | .550     | .560 |       |
| d3       | 12.29       | 12.93 | .484     | .509 |       |
| E        | 9.63        | 10.74 | .379     | .423 | 4     |
| e        | 2.54 BSC    |       | .100 BSC |      |       |
| L        | 13.21       | 13.72 | .520     | .540 |       |
| L1       | 3.10        | 3.68  | .122     | .145 | 3     |
| n        | 6.05        | 6.60  | .238     | .260 |       |
| $\phi P$ | 3.05        | 3.45  | .120     | .136 |       |
| u        | 2.39        | 2.49  | .094     | .098 | 6     |
| v        | 0.41        | 0.51  | .016     | .020 | 6     |
| $\phi 1$ | -           | 45°   | -        | 45°  |       |

## TO-220 Full-Pak Part Marking Information

EXAMPLE: THIS IS AN IRFI840G  
 WITH ASSEMBLY  
 LOT CODE 3432  
 ASSEMBLED ON WW24, 2001  
 IN THE ASSEMBLY LINE "K"

Note: "P" in assembly line position indicates "Lead-Free"



TO-220AB Full-Pak packages are not recommended for Surface Mount Application.

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

**Qualification Information<sup>†</sup>**

|                                   |   |     |
|-----------------------------------|---|-----|
| <b>Qualification Level</b>        | Industrial<br>(per JEDEC JESD47F) <sup>††</sup> |     |
| <b>Moisture Sensitivity Level</b> | TO-220 Full-Pak                                 | N/A |
| <b>RoHS Compliant</b>             | Yes   |     |

† Qualification standards can be found at International Rectifier's web site: <http://www.irf.com/product-info/reliability/>

†† Applicable version of JEDEC standard at the time of product release.

**Revision History**

| <b>Date</b> | <b>Comments</b>  |
|-------------|--|
| 11/18/2014  | <ul style="list-style-type: none"> <li>Updated <math>E_{AS(L=1mH)} = 407mJ</math> on page 2</li> <li>Updated note 8 "Limited by <math>T_{Jmax}</math>, starting <math>T_J = 25^{\circ}C</math>, <math>L = 1mH</math>, <math>R_G = 50\Omega</math>, <math>I_{AS} = 29A</math>, <math>V_{GS} = 10V</math>". on page 2</li> </ul> |
| 12/16/2015  | <ul style="list-style-type: none"> <li>Updated datasheet with corporate template</li> <li>Corrected typo test condition for Switch time ID from "57A" to "30A" on page 3.</li> </ul>   |

**Published by  
Infineon Technologies AG  
81726 München, Germany**

**© Infineon Technologies AG 2015  
All Rights Reserved.**

**IMPORTANT NOTICE**

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenhheitsgarantie"). With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

For further information on the product, technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies office ([www.infineon.com](http://www.infineon.com)).

**WARNINGS**

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies office.

Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.

## **IMPORTANT NOTICE**

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffheitsgarantie").

With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

For further information on the product, technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies office ([www.infineon.com](http://www.infineon.com)).

## **WARNINGS**

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies office.

Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.